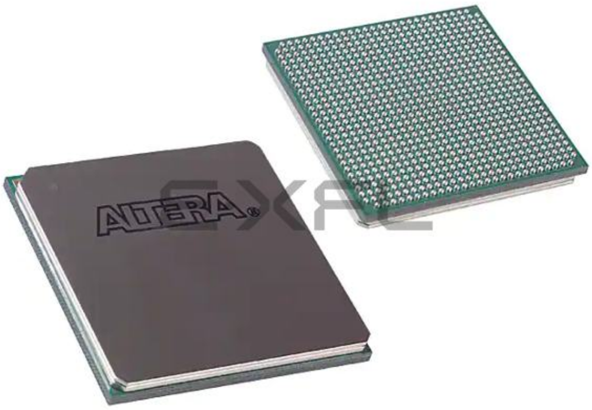


Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

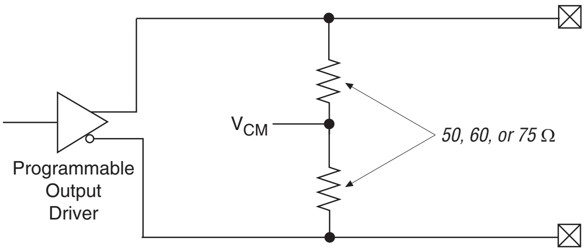
Details	
Product Status	Obsolete
Number of LABs/CLBs	1694
Number of Logic Elements/Cells	33880
Total RAM Bits	1369728
Number of I/O	361
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	780-BBGA
Supplier Device Package	780-FBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep2sgx30df780c3n

Pre-emphasis percentage is defined as $(V_{MAX}/V_{MIN} - 1) \times 100$, where V_{MAX} is the differential emphasized voltage (peak-to-peak) and V_{MIN} is the differential steady-state voltage (peak-to-peak).

Programmable Termination

The programmable termination can be statically set in the Quartus II software. The values are 100 Ω, 120 Ω, 150 Ω, and external termination. Figure 2–11 shows the setup for programmable termination.

Figure 2–11. Programmable Transmitter Terminations



PCI Express Receiver Detect

The Stratix II GX transmitter buffer has a built-in receiver detection circuit for use in PIPE mode. This circuit provides the ability to detect if there is a receiver downstream by sending out a pulse on the channel and monitoring the reflection. This mode requires the transmitter buffer to be tri-stated (in electrical idle mode).

PCI Express Electric Idles (or Individual Transmitter Tri-State)

The Stratix II GX transmitter buffer supports PCI Express electrical idles. This feature is only active in PIPE mode. The `tx_forceelecidle` port puts the transmitter buffer in electrical idle mode. This port is available in all PCI Express power-down modes and has specific usage in each mode.

Receiver Path

This section describes the data path through the Stratix II GX receiver. The Stratix II GX receiver consists of the following blocks:

- Receiver differential input buffer
- Receiver PLL lock detector, signal detector, and run length checker
- Clock/data recovery (CRU) unit
- Deserializer
- Pattern detector
- Word aligner

This module detects word boundaries for the 8B/10B-based protocols, SONET, 16-bit, and 20-bit proprietary protocols. This module is also used to align to specific programmable patterns in PRBS7/23 test mode.

Pattern Detection

The programmable pattern detection logic can be programmed to align word boundaries using a single 7-, 8-, 10-, 16-, 20, or 32-bit pattern. The pattern detector can either do an exact match, or match the exact pattern and the complement of a given pattern. Once the programmed pattern is found, the data stream is aligned to have the pattern on the LSB portion of the data output bus.

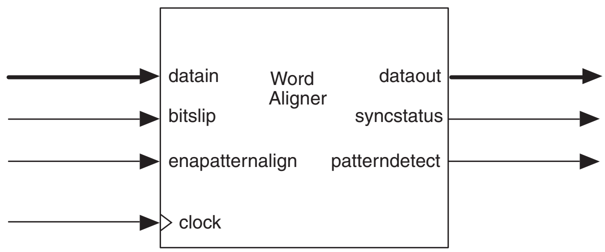
XAUI, GIGE, PCI Express, and Serial RapidIO standards have embedded state machines for symbol boundary synchronization. These standards use K28.5 as their 10-bit programmed comma pattern. Each of these standards uses different algorithms before signaling symbol boundary acquisition to the FPGA.

The pattern detection logic searches from the LSB to the most significant bit (MSB). If multiple patterns are found within the search window, the pattern in the lower portion of the data stream (corresponding to the pattern received earlier) is aligned and the rest of the matching patterns are ignored.

Once a pattern is detected and the data bus is aligned, the word boundary is locked. The two detection status signals (`rx_syncstatus` and `rx_patterndetect`) indicate that an alignment is complete.

Figure 2–18 is a block diagram of the word aligner.

Figure 2–18. Word Aligner



The dynamic reconfiguration block can dynamically reconfigure the following PMA settings:

- Pre-emphasis settings
- Equalizer and DC gain settings
- Voltage Output Differential (V_{OD}) settings

The channel reconfiguration allows you to dynamically modify the data rate, local dividers, and the functional mode of the transceiver channel.

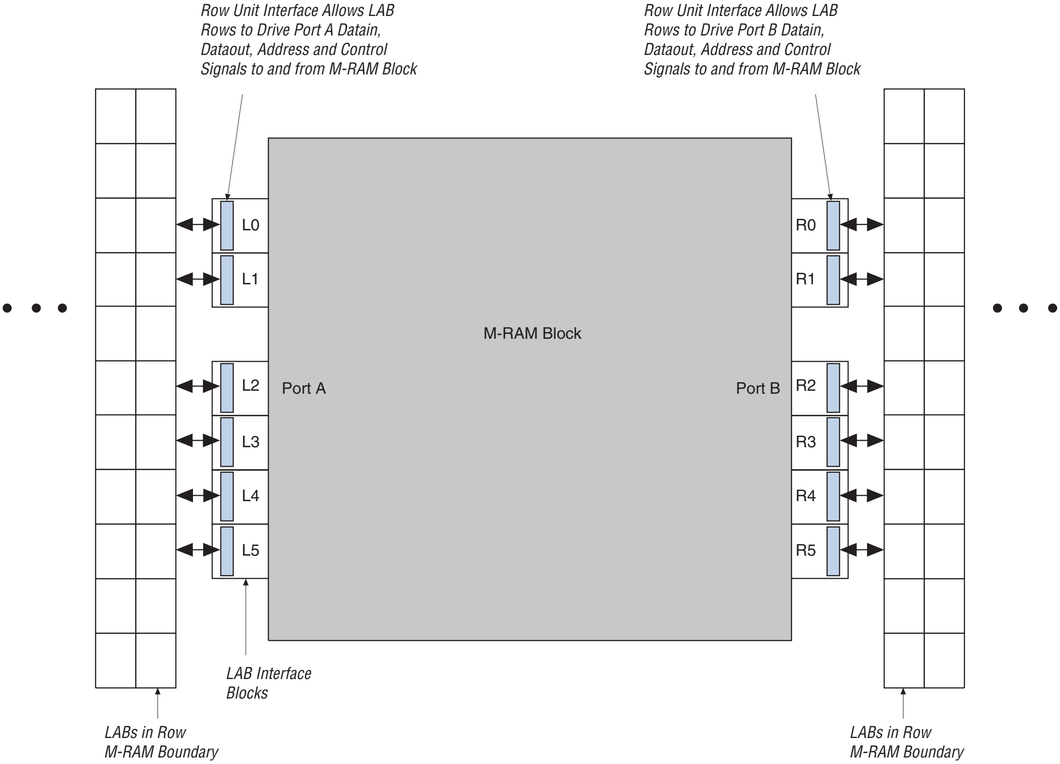
Refer to the *Stratix II GX Device Handbook*, volume 2, for more information.

The dynamic reconfiguration block requires an input clock between 2.5 MHz and 50 MHz. The clock for the dynamic reconfiguration block is derived from a high-speed clock and divided down using a counter.

Individual Power Down and Reset for the Transmitter and Receiver

Stratix II GX transceivers offer a power saving advantage with their ability to shut off functions that are not needed. The device can individually reset the receiver and transmitter blocks and the PLLs. The Stratix II GX device can either globally or individually power down and reset the transceiver. Table 2–16 shows the connectivity between the reset signals and the Stratix II GX transceiver blocks. These reset signals can be controlled from the FPGA or pins.

Figure 2–55. M-RAM Block LAB Row Interface Note (1)



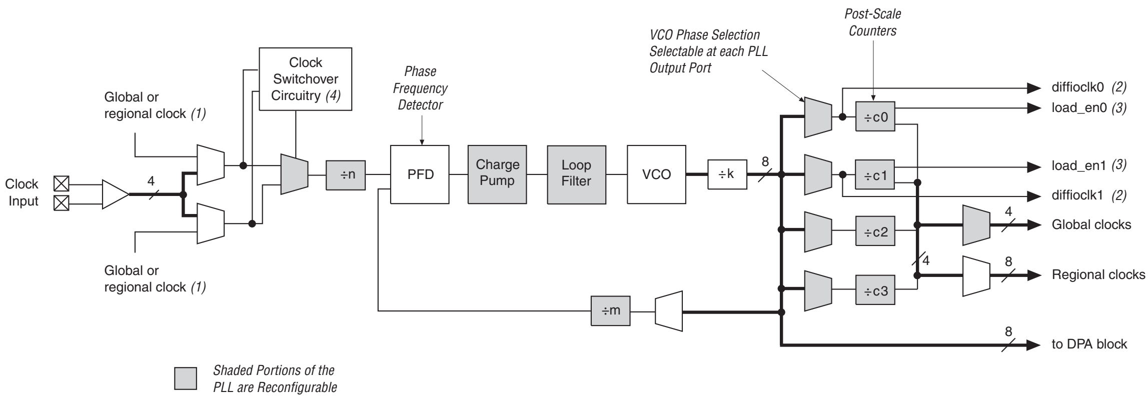
Note to Figure 2–55:

(1) Only R24 and C16 interconnects cross the M-RAM block boundaries.

Table 2–23. DSP Block Signal Sources and Destinations

LAB Row at Interface	Control Signals Generated	Data Inputs	Data Outputs
0	clock0 aclr0 ena0 mult01_saturate addnsub1_round/ accum_round addnsub1 signa sourcea sourceb	A1[17..0] B1[17..0]	OA[17..0] OB[17..0]
1	clock1 aclr1 ena1 accum_saturate mult01_round accum_sload sourcea sourceb mode0	A2[17..0] B2[17..0]	OC[17..0] OD[17..0]
2	clock2 aclr2 ena2 mult23_saturate addnsub3_round/ accum_round addnsub3 sign_b sourcea sourceb	A3[17..0] B3[17..0]	OE[17..0] OF[17..0]
3	clock3 aclr3 ena3 accum_saturate mult23_round accum_sload sourcea sourceb mode1	A4[17..0] B4[17..0]	OG[17..0] OH[17..0]

Figure 2–75. Stratix II GX Device Fast PLL



Notes to Figure 2–75:

(1) The global or regional clock input can be driven by an output from another PLL, a pin-driven dedicated global or regional clock, or through a clock control block provided the clock control block is fed by an output from another PLL or a pin-driven dedicated global or regional clock. An internally generated global signal cannot drive the PLL.

(2) In high-speed differential I/O support mode, this high-speed PLL clock feeds the serializer/deserializer (SERDES) circuitry. Stratix II GX devices only support one rate of data transfer per fast PLL in high-speed differential I/O support mode.

(3) This signal is a differential I/O SERDES control signal.

(4) Stratix II GX fast PLLs only support manual clock switchover.

Refer to the *PLLs in Stratix II & Stratix II GX Devices* chapter in volume 2 of the *Stratix II GX Device Handbook* for more information on enhanced and fast PLLs. Refer to "High-Speed Differential I/O with DPA Support" on page 2–136 for more information on high-speed differential I/O support.

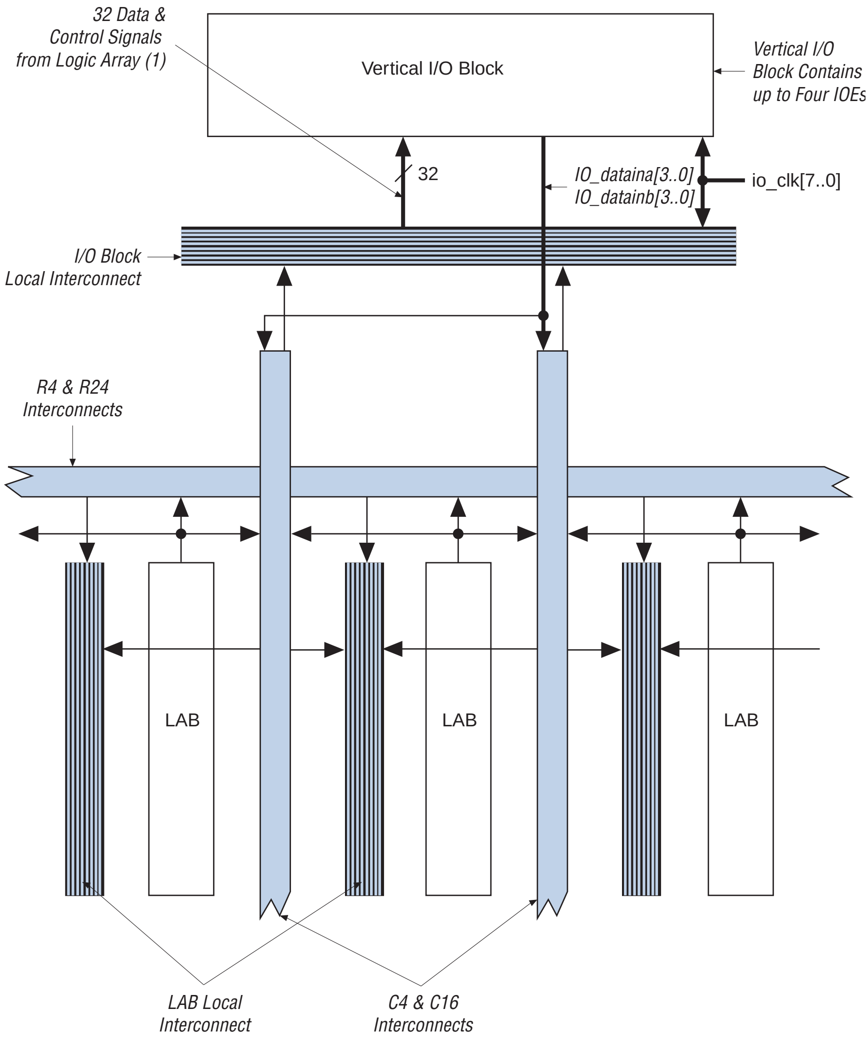
I/O Structure

The Stratix II GX IOEs provide many features, including:

- Dedicated differential and single-ended I/O buffers
- 3.3-V, 64-bit, 66-MHz PCI compliance
- 3.3-V, 64-bit, 133-MHz PCI-X 1.0 compliance
- Joint Test Action Group (JTAG) boundary-scan test (BST) support
- On-chip driver series termination
- On-chip termination for differential standards
- Programmable pull-up during configuration
- Output drive strength control
- Tri-state buffers
- Bus-hold circuitry
- Programmable pull-up resistors
- Programmable input and output delays

Figure 2–78 shows how a column I/O block connects to the logic array.

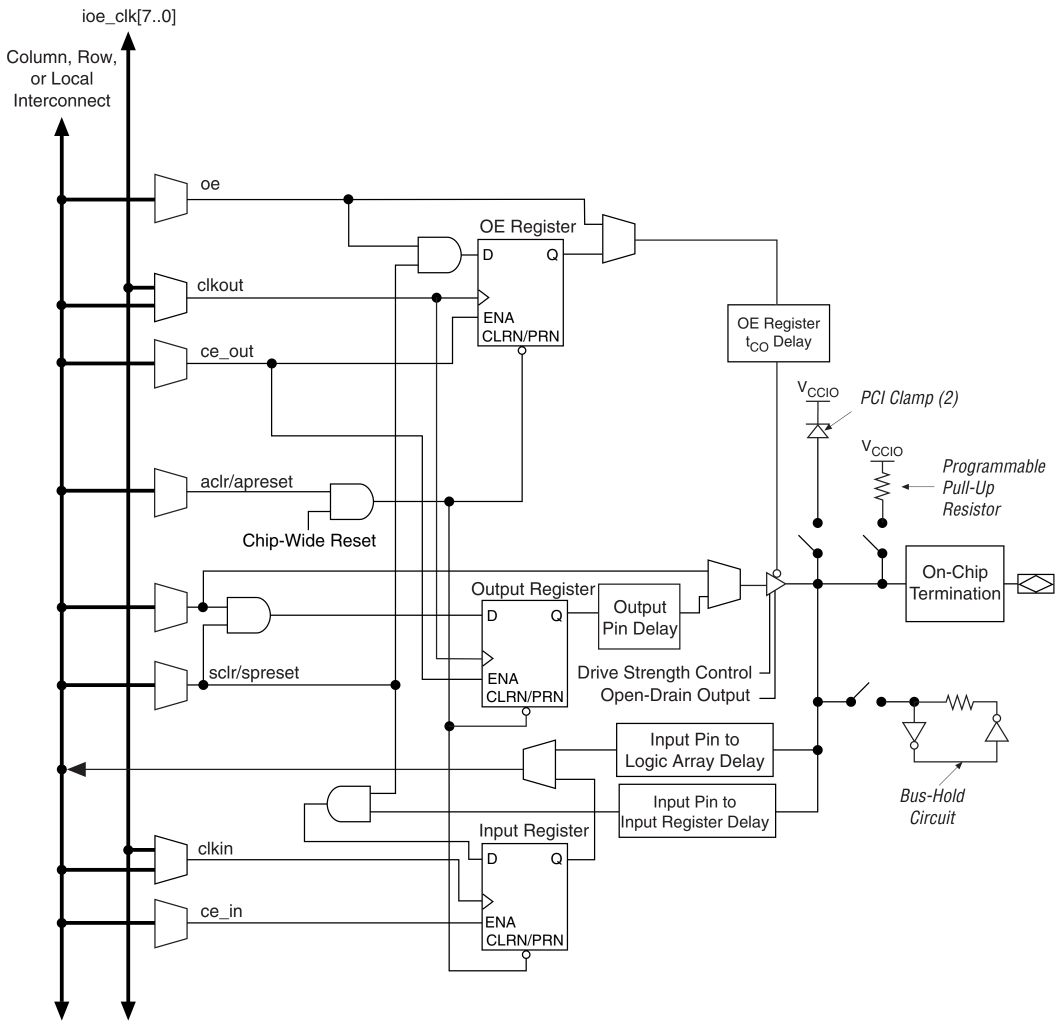
Figure 2–78. Column I/O Block Connection to the Interconnect



Note to Figure 2–78:

(1) The 32 data and control signals consist of eight data out lines: four lines each for DDR applications `io_dataouta[3..0]` and `io_dataoutb[3..0]`, four output enables `io_oe[3..0]`, four input clock enables `io_ce_in[3..0]`, four output clock enables `io_ce_out[3..0]`, four clocks `io_clk[3..0]`, four asynchronous clear and preset signals `io_aclr/apreset[3..0]`, and four synchronous clear and preset signals `io_sclr/spreset[3..0]`.

Figure 2–81. Stratix II GX IOE in Bidirectional I/O Configuration *Note (1)*



Notes to Figure 2–81:

(1) All input signals to the IOE can be inverted at the IOE.

(2) The optional PCI clamp is only available on column I/O pins.

The Stratix II GX device IOE includes programmable delays that can be activated to ensure input IOE register-to-logic array register transfers, input pin-to-logic array register transfers, or output IOE register-to-pin transfers.

On-Chip Parallel Termination with Calibration

Stratix II GX devices support on-chip parallel termination with calibration for column I/O pins only. There is one calibration circuit for the top I/O banks and one circuit for the bottom I/O banks. Each on-chip parallel termination calibration circuit compares the total impedance of each I/O buffer to the external 50-Ω resistors connected to the RUP and RDN pins and dynamically enables or disables the transistors until they match. Calibration occurs at the end of device configuration. Once the calibration circuit finds the correct impedance, it powers down and stops changing the characteristics of the drivers.

On-chip parallel termination with calibration is only supported for input pins.

For more information about on-chip termination supported by Stratix II devices, refer to the *Selectable I/O Standards in Stratix II & Stratix II GX Devices* chapter in volume 2 of the *Stratix II GX Device Handbook*.

For more information about tolerance specifications for on-chip termination with calibration, refer to the *DC & Switching Characteristics* chapter in volume 1 of the *Stratix II GX Device Handbook.*

MultiVolt I/O Interface

The Stratix II GX architecture supports the MultiVolt I/O interface feature that allows Stratix II GX devices in all packages to interface with systems of different supply voltages. The Stratix II GX VCCINT pins must always be connected to a 1.2-V power supply. With a 1.2-V V_{CCINT} level, input pins are 1.2-, 1.5-, 1.8-, 2.5-, and 3.3-V tolerant. The VCCIO pins can be connected to either a 1.2-, 1.5-, 1.8-, 2.5-, or 3.3-V power supply, depending on the output requirements. The output levels are compatible with systems of the same voltage as the power supply (for example, when VCCIO pins are connected to a 1.5-V power supply, the output levels are compatible with 1.5-V systems). The Stratix II GX VCCPD power pins must be connected to a 3.3-V power supply. These power pins are used to supply the pre-driver power to the output buffers, which increases the performance of the output pins. The VCCPD pins also power configuration input pins and JTAG input pins.

Table 4–6. Stratix II GX Transceiver Block AC Specification (Part 5 of 6)											
Symbol / Description	Conditions	-3 Speed Commercial Speed Grade			-4 Speed Commercial and Industrial Speed Grade			-5 Speed Commercial Speed Grade			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
Data rate		600	-	6375	600	-	5000	600	-	4250	Mbps
V_{OCM}	V_{OCM} = 0.6 V setting	580±10%			580±10%			580±10%			mV
	V_{OCM} = 0.7 V setting	680±10%			680±10%			680±10%			mV
On-chip termination resistors	100 Ω setting	108±10%			108±10%			108±10%			Ω
	120 Ω setting	125±10%			125±10%			125±10%			Ω
	150 Ω setting	152±10%			152±10%			152±10%			Ω
Return loss differential mode	312 MHz to 625 MHz (XAUI): -10 dB 625 MHz to 3.125 GHz (XAUI): -10 dB/decade slope 50 MHz to 1.25 GHz (PCI-E): -10dB 100 MHz to 4.875 GHz (OIF/CEI): -8db 4.875 GHz to 10 GHz (OIF/CEI): 16.6 dB/decade slope										
Return loss common mode	50 MHz to 1.25 GHz (PCI-E): -6dB 100 MHz to 4.875 GHz (OIF/CEI): -6db 4.875 GHz to 10 GHz (OIF/CEI): 16.6 dB/decade slope										
Rise time		35	-	65	35	-	65	35	-	65	ps
Fall time		35	-	65	35	-	65	35	-	65	ps
Intra differential pair skew	V_{OD} = 800 mV	-	-	15	-	-	15	-	-	15	ps
Intra-transceiver block skew (x4)		-	-	100	-	-	100	-	-	100	ps
Inter-transceiver block skew (x8)		-	-	300	-	-	300	-	-	300	ps
TXPLL (TXPLL0 and TXPLL1)											
VCO frequency range (low gear)		500	-	1562.5	500	-	1562.5	500	-	1562.5	MHz
VCO frequency range (high gear)		1562.5		3187.5	1562.5		2500	1562.5	-	2125	MHz

Table 4–19. Stratix II GX Transceiver Block AC Specification Notes (1), (2), (3) (Part 7 of 19)											
Symbol/ Description	**Conditions**	**-3 Speed Commercial Speed Grade**			**-4 Speed Commercial and Industrial Speed Grade**			**-5 Speed Commercial Speed Grade**			**Unit**
		Min	**Typ**	**Max**	**Min**	**Typ**	**Max**	**Min**	**Typ**	**Max**	
Sinusoidal Jitter Tolerance (peak-to-peak)	Jitter Frequency = 22.1 KHz Data Rate = 1.25, 2.5, 3.125 Gbps `REFCLK` = 125 MHz Pattern = CJPAT Equalizer Setting = 0 for 1.25 Gbps Equalizer Setting = 6 for 2.5 Gbps Equalizer Setting = 6 for 3.125 Gbps	> 8.5			> 8.5			> 8.5			UI
	Jitter Frequency = 1.875 MHz Data Rate = 1.25, 2.5, 3.125 Gbps `REFCLK` = 125 MHz Pattern = CJPAT Equalizer Setting = 0 for 1.25 Gbps Equalizer Setting = 6 for 2.5 Gbps Equalizer Setting = 6 for 3.125 Gbps	> 0.1			> 0.1			> 0.1			UI
	Jitter Frequency = 20 MHz Data Rate = 1.25, 2.5, 3.125 Gbps `REFCLK` = 125 MHz Pattern = CJPAT Equalizer Setting = 0 for 1.25 Gbps Equalizer Setting = 6 for 2.5 Gbps Equalizer Setting = 6 for 3.125 Gbps	> 0.1			> 0.1			> 0.1			UI

Table 4–19. Stratix II GX Transceiver Block AC Specification Notes (1), (2), (3) (Part 13 of 19)											
Symbol/ Description	Conditions	-3 Speed Commercial Speed Grade			-4 Speed Commercial and Industrial Speed Grade			-5 Speed Commercial Speed Grade			Unit
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
CPRI Receiver Jitter Tolerance *(15)*											
Deterministic Jitter Tolerance (peak-to-peak)	Data Rate = 614.4 Mbps, 1.2288 Gbps, 2.4576 Gbps `REFCLK` = 61.44 MHz for 614.4 Mbps `REFCLK` = 122.88 MHz for 1.2288 Gbps and 2.4576 Gbps Pattern = CJPAT Equalizer Setting = 6 DC Gain = 0 dB	> 0.4			> 0.4			N/A			UI
Combined Deterministic and Random Jitter Tolerance (peak-to-peak)	Data Rate = 614.4 Mbps, 1.2288 Gbps, 2.4576 Gbps `REFCLK` = 61.44 MHz for 614.4 Mbps `REFCLK` = 122.88 MHz for 1.2288 Gbps and 2.4576 Gbps Pattern = CJPAT Equalizer Setting = 6 DC Gain = 0 dB	> 0.66			> 0.66			N/A			UI

Table 4–22. PCS Latency (Part 3 of 3) Note (1)											
Functional Mode	Configuration	Receiver PCS Latency									
		Word Aligner	Deskew FIFO	Rate Matcher (3)	8B/10B Decoder	Receiver State Machine	Byte De-serializer	Byte Order	Receiver Phase Comp FIFO	Receiver PIPE	Sum (2)
BASIC Double Width	16/20-bit channel width; with Rate Matcher	4-5	-	11-13	1	-	1	1	1-2	-	19-23
	16/20-bit channel width; without Rate Matcher	4-5	-	-	1	-	1	1	1-2	-	8-10
	32/40-bit channel width; with Rate Matcher	2-2.5	-	5.5-6.5	0.5	-	1	1	1-2	-	11-14
	32/40-bit channel width; without Rate Matcher	2-2.5	-	-	0.5	-	1	1-3	1-2	-	6-9

Notes to Table 4–21:

(1) The latency numbers are with respect to the PLD-transceiver interface clock cycles.

(2) The total latency number is rounded off in the Sum column.

(3) The rate matcher latency shown is the steady state latency. Actual latency may vary depending on the skip ordered set gap allowed by the protocol, actual PPM difference between the reference clocks, and so forth.

(4) For CPRI 614 Mbps and 1.228 Gbps data rates, the Quartus II software customizes the PLD-transceiver interface clocking to achieve zero clock cycle uncertainty in the receiver phase compensation FIFO latency. For more details, refer to the *CPRI Mode* section in the *Stratix II GX Transceiver Architecture Overview* chapter in volume 2 of the *Stratix II GX Device Handbook*

EP2SGX90 Clock Timing Parameters

Tables 4–71 through 4–74 show the maximum clock timing parameters for EP2SGX90 devices.

Table 4–71. EP2SGX90 Column Pins Global Clock Timing Parameters

Parameter	Fast Corner		-3 Speed Grade	-4 Speed Grade	-5 Speed Grade	Units
	Industrial	Commercial				
t_{CIN}	1.861	1.878	3.115	3.465	4.143	ns
t_{COUT}	1.696	1.713	2.873	3.195	3.819	ns
t_{PLLCIN}	-0.254	-0.237	0.171	0.179	0.206	ns
$t_{PLLCOUT}$	-0.419	-0.402	-0.071	-0.091	-0.118	ns

Table 4–72. EP2SGX90 Row Pins Global Clock Timing Parameters

Parameter	Fast Corner		-3 Speed Grade	-4 Speed Grade	-5 Speed Grade	Units
	Industrial	Commercial				
t_{CIN}	1.634	1.650	2.768	3.076	3.678	ns
t_{COUT}	1.639	1.655	2.764	3.072	3.673	ns
t_{PLLCIN}	-0.481	-0.465	-0.189	-0.223	-0.279	ns
$t_{PLLCOUT}$	-0.476	-0.46	-0.193	-0.227	-0.284	ns

Table 4–73. EP2SGX90 Column Pins Regional Clock Timing Parameters

Parameter	Fast Corner		-3 Speed Grade	-4 Speed Grade	-5 Speed Grade	Units
	Industrial	Commercial				
t_{CIN}	1.688	1.702	2.896	3.224	3.856	ns
t_{COUT}	1.551	1.569	2.893	3.220	3.851	ns
t_{PLLCIN}	-0.105	-0.089	0.224	0.241	0.254	ns
$t_{PLLCOUT}$	-0.27	-0.254	0.224	0.241	0.254	ns

Table 4–93. Stratix II GX Maximum Output Clock Rate for Dedicated Clock Pins (Part 2 of 4)

I/O Standard	Drive Strength	-3 Speed Grade	-4 Speed Grade	-5 Speed Grade	Unit
2.5 V	4 mA	230	194	180	MHz
	8 mA	430	380	380	MHz
	12 mA	630	575	550	MHz
	16 mA *(1)*	930	845	820	MHz
1.8 V	2 mA	120	109	104	MHz
	4 mA	285	250	230	MHz
	6 mA	450	390	360	MHz
	8 mA	660	570	520	MHz
	10 mA	905	805	755	MHz
	12 mA *(1)*	1131	1040	990	MHz
1.5 V	2 mA	244	200	180	MHz
	4 mA	470	370	325	MHz
	6 mA	550	430	375	MHz
	8 mA *(1)*	625	495	420	MHz
SSTL-2 Class I	8 mA	400	300	300	MHz
	12 mA *(1)*	400	400	350	MHz
SSTL-2 Class II	16 mA	350	350	300	MHz
	20 mA	400	350	350	MHz
	24 mA *(1)*	400	400	350	MHz
SSTL-18 Class I	4 mA	200	150	150	MHz
	6 mA	350	250	200	MHz
	8 mA	450	300	300	MHz
	10 mA	500	400	400	MHz
	12 mA *(1)*	650	550	400	MHz
SSTL-18 Class II	8 mA	200	200	150	MHz
	16 mA	400	350	350	MHz
	18 mA	450	400	400	MHz
	20 mA *(1)*	550	500	450	MHz
1.8-V HSTL Class I	4 mA	300	300	300	MHz
	6 mA	500	450	450	MHz
	8 mA	650	600	600	MHz
	10 mA	700	650	600	MHz
	12 mA *(1)*	700	700	650	MHz

Table 4–97. Maximum Output Clock Toggle Rate Derating Factors (Part 3 of 5)										
I/O Standard	Drive Strength	Maximum Output Clock Toggle Rate Derating Factors (ps/pF)								
		Column I/O Pins			Row I/O Pins			Dedicated Clock Outputs		
		-3	-4	-5	-3	-4	-5	-3	-4	-5
SSTL-18 Class II	8 mA	173	206	206	-	-	-	155	206	206
	16 mA	150	160	160	-	-	-	140	160	160
	18 mA	120	130	130	-	-	-	110	130	130
	20 mA	109	127	127	-	-	-	94	127	127
2.5-V SSTL-2 Class I	8 mA	364	680	680	364	680	680	350	680	680
	12 mA	163	207	207	163	207	207	188	207	207
2.5-V SSTL-2 Class II	16 mA	118	147	147	118	147	147	94	147	147
	20 mA	99	122	122	-	-	-	87	122	122
	24 mA	91	116	116	-	-	-	85	116	116
1.8-V SSTL-18 Class I	4 mA	458	570	570	458	570	570	505	570	570
	6 mA	305	380	380	305	380	380	336	380	380
	8 mA	225	282	282	225	282	282	248	282	282
	10 mA	167	220	220	167	220	220	190	220	220
	12 mA	129	175	175	-	-	-	148	175	175
1.8-V SSTL-18 Class II	8 mA	173	206	206	-	-	-	155	206	206
	16 mA	150	160	160	-	-	-	140	160	160
	18 mA	120	130	130	-	-	-	110	130	130
	20 mA	109	127	127	-	-	-	94	127	127
1.8-V HSTL Class I	4 mA	245	282	282	245	282	282	229	282	282
	6 mA	164	188	188	164	188	188	153	188	188
	8 mA	123	140	140	123	140	140	114	140	140
	10 mA	110	124	124	110	124	124	108	124	124
	12 mA	97	110	110	97	110	110	104	110	110
1.8-V HSTL Class II	16 mA	101	104	104	-	-	-	99	104	104
	18 mA	98	102	102	-	-	-	93	102	102
	20 mA	93	99	99	-	-	-	88	99	99
1.5-V HSTL Class I	4 mA	168	196	196	168	196	196	188	196	196
	6 mA	112	131	131	112	131	131	125	131	131
	8 mA	84	99	99	84	99	99	95	99	99
	10 mA	87	98	98	-	-	-	90	98	98
	12 mA	86	98	98	-	-	-	87	98	98

Table 4–97. Maximum Output Clock Toggle Rate Derating Factors (Part 5 of 5)										
I/O Standard	**Drive Strength**	**Maximum Output Clock Toggle Rate Derating Factors (ps/pF)**								
		Column I/O Pins			**Row I/O Pins**			**Dedicated Clock Outputs**		
		-3	**-4**	**-5**	**-3**	**-4**	**-5**	**-3**	**-4**	**-5**
1.5-V differential HSTL Class II *(3)*	16 mA	95	101	101	-	-	-	96	101	101
	18 mA	95	100	100	-	-	-	101	100	100
	20 mA	94	101	101	-	-	-	104	101	101
3.3-V PCI		134	177	177	-	-	-	143	177	177
3.3-V PCI-X		134	177	177	-	-	-	143	177	177
LVDS		-	-	-	155 *(1)*	155 *(1)*	155 *(1)*	134	134	134
LVPECL *(4)*		-	-	-	-	-	-	134	134	134
3.3-V LVTTL	OCT 50 Ω	133	152	152	133	152	152	147	152	152
2.5-V LVTTL	OCT 50 Ω	207	274	274	207	274	274	235	274	274
1.8-V LVTTL	OCT 50 Ω	151	165	165	151	165	165	153	165	165
3.3-V LVCMOS	OCT 50 Ω	300	316	316	300	316	316	263	316	316
1.5-V LVCMOS	OCT 50 Ω	157	171	171	157	171	171	174	171	171
SSTL-2 Class I	OCT 50 Ω	121	134	134	121	134	134	77	134	134
SSTL-2 Class II	OCT 25 Ω	56	101	101	56	101	101	58	101	101
SSTL-18 Class I	OCT 50 Ω	100	123	123	100	123	123	106	123	123
SSTL-18 Class II	OCT 25 Ω	61	110	110	-	-	-	59	110	110
1.2-V HSTL *(2)*	OCT 50 Ω	95	-	-	-	-	-	95	-	-

(1) For LVDS output on row I/O pins the toggle rate derating factors apply to loads larger than 5 pF. In the derating calculation, subtract 5 pF from the intended load value in pF for the correct result. For a load less than or equal to 5 pF, refer to Tables 4–91 through 4–95 for output toggle rates.
(2) 1.2-V HSTL is only supported on column I/O pins on -3 devices.
(3) Differential HSTL and SSTL is only supported on column clock and DQS outputs.
(4) LVPECL is only supported on column clock outputs.

Table 4–109 shows the high-speed I/O timing specifications for -5 speed grade Stratix II GX devices.

Table 4–109. High-Speed I/O Specifications for -5 Speed Grade *Notes (1), (2)*

Symbol	Conditions			-5 Speed Grade			Unit
				Min	Typ	Max	
$f_{IN} = f_{HSDR}$ / W	W = 2 to 32 (LVDS, HyperTransport technology) *(3)*			16		420	MHz
	W = 1 (SERDES bypass, LVDS only)			16		500	MHz
	W = 1 (SERDES used, LVDS only)			150		640	MHz
f_{HSDR} (data rate)	J = 4 to 10 (LVDS, HyperTransport technology)			150		840	Mbps
	J = 2 (LVDS, HyperTransport technology)			*(4)*		700	Mbps
	J = 1 (LVDS only)			*(4)*		500	Mbps
$f_{HSDRDPA}$ (DPA data rate)	J = 4 to 10 (LVDS, HyperTransport technology)			150		840	Mbps
TCCS	All differential I/O standards			-		200	ps
SW	All differential I/O standards			440		-	ps
Output jitter						190	ps
Output t_{RISE}	All differential I/O standards					290	ps
Output t_{FALL}	All differential I/O standards					290	ps
t_{DUTY}				45	50	55	%
DPA run length						6,400	UI
DPA jitter tolerance	Data channel peak-to-peak jitter			0.44			UI
DPA lock time							Number of repetitions
	SPI-4	0000000000 1111111111	10%	256			
	Parallel Rapid I/O	00001111	25%	256			
		10010000	50%	256			
	Miscellaneous	10101010	100%	256			
		01010101		256			

(1) When J = 4 to 10, the SERDES block is used.
(2) When J = 1 or 2, the SERDES block is bypassed.
(3) The input clock frequency and the W factor must satisfy the following fast PLL VCO specification: $150 \leq$ input clock frequency $\times$ W ≤ 840.
(4) The minimum specification is dependent on the clock source (fast PLL, enhanced PLL, clock pin, and so on) and the clock routing resource (global, regional, or local) utilized. The I/O differential buffer and input register do not have a minimum toggle rate.

Figure 4–14. Stratix II GX JTAG Waveforms.

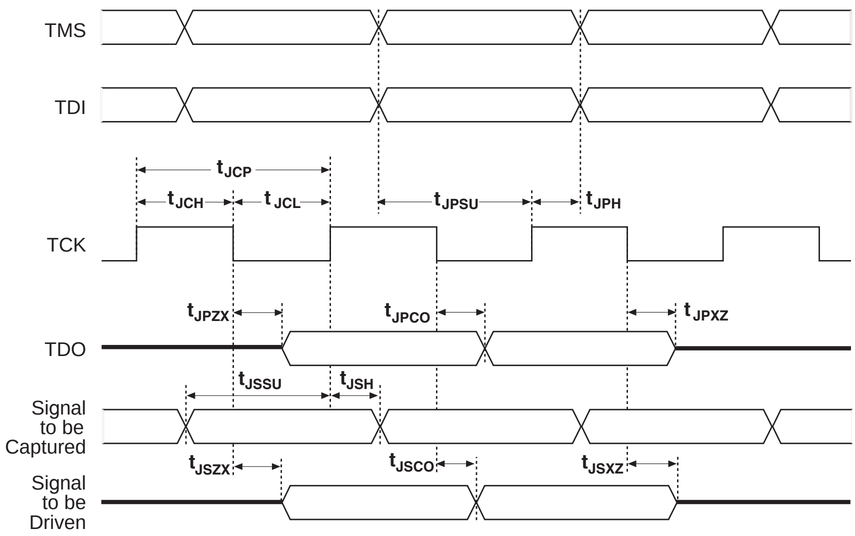


Table 4–117 shows the JTAG timing parameters and values for Stratix II GX devices.

Table 4–117. Stratix II GX JTAG Timing Parameters and Values

Symbol	Parameter	Min	Max	Unit
t_{JCP}	TCK clock period	30		ns
t_{JCH}	TCK clock high time	12		ns
t_{JCL}	TCK clock low time	12		ns
t_{JPSU}	JTAG port setup time	4		ns
t_{JPH}	JTAG port hold time	5		ns
t_{JPCO}	JTAG port clock to output		9	ns
t_{JPZX}	JTAG port high impedance to valid output		9	ns
t_{JPXZ}	JTAG port valid output to high impedance		9	ns
t_{JSSU}	Capture register setup time	4		ns
t_{JSH}	Capture register hold time	5		ns
t_{JSCO}	Update register clock to output		12	ns
t_{JSZX}	Update register high impedance to valid output		12	ns
t_{JSXZ}	Update register valid output to high impedance		12	ns

Table 4–118. Document Revision History (Part 4 of 5)

Date and Document Version	Changes Made	Summary of Changes
June 2006, v4.0	• Updated Table 6–5. • Updated Table 6–6. • Updated all values in Table 6–7. • Added Tables 6–8 and 6–9. • Added Figures 6–1 through 6–4. • Updated Table 6–18. • Updated Tables 6–85 through 6–96. • Added Table 6–80, Stratix II GX Maximum Output Clock Rate for Dedicated Clock Pins. • Updated Table 6–100. • In "I/O Timing Measurement Methodology" section, updated Table 6–42. • In "Internal Timing Parameters" section, updated Tables 6–43 through 6–48. • In "Stratix II GX Clock Timing Parameters" section, updated Tables 6–50 through 6–65. • In "IOE Programmable Delay" section, updated Tables 6–67 and 6–68. • In "I/O Delays" section, updated Tables 6–71 through 6–74. • In "Maximum Input & Output Clock Toggle Rate" section, updated Tables 6–75 through 6–83. • In "DCD Measurement Techniques" section, updated Tables 6–85 through 6–92. • In "High-Speed I/O Specifications" section, updated Tables 6–94 through 6–96. • In "External Memory Interface Specifications" section, updated Table 6–100.	• Removed rows for V_{ID}, V_{OD}, V_{ICM}, and V_{OCM} from Table 6–5. • Updated values for rx, tx, and `refclkb` in Table 6–6. • Removed table containing 1.2-V PCML I/O information. That information is in Table 6–7. • Added values to Table 6–100.